Issue Classification

	App	lication	on/Con	trol No
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BATTHISH ET AL.

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

San Juan, Martin Jeriko P

2132

ORIGINAL				INTERNATIONAL CLASSIFICATION											
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San Juan, Martin Jeriko 9/10/2007 P			GILBERTO BARRON JA						Total Claims Allowed:						
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Alla alklon				TECHNOLOGY CENTER 2100						O.G. Print Claim(s)				O.G. Print Figure	
(Legal Instruments (Date) Examiner)				(Primary	(Primary Examiner) (Date) 4/4					Date) 9/14/07	1				7